

REMARKS

Claim Rejections 35 U.S.C. § 103 (a)

Claims 1-5

The Examiner has rejected claims 1-5 under 35 U.S.C. §103 (a) as being unpatentable over Satya et al. (US 6,528,818) and Browning et al. (US 5,580,829), both previously applied and further in view of Stearns et al. (US 5,715,385) presently newly applied.

Applicants respectfully disagree with the Examiner. Applicants have amended claim 1. Support is provided in the specification at lines 10-13, 19-22 on page 8; lines 1-2, 9-12, 28-30 on page 9; and lines 3-15 on page 10.

Claim 1, as amended, of Applicants' claimed invention, claims a structure (250) that includes: a first set (245) of features located in a scribeline, the first set of features being a subset of product features; and a second set (255) of features located in the scribeline and adjacent to the first set of features, the second set of features differing from the first set of features in pattern factor, the second set of features spread across a smaller space than the first set of features, the second set of features created by geometric transformation of the product features, including rotating (33), space scaling (36), and linewidth scaling (39). See Figure 3 and Figure 5.

In contrast, the Satya et al. reference cited by the Examiner teaches a die array (202), as shown in figure 4A, that includes test dies (204) and product dies (206) separated by scribelines, as shown in Figure 4B, where test structures are located within the test die (204). See Figure 4B. Also, see Col. 11, lines 38-44.

The Examiner states that Satya et al. further teaches that each test die (204) is configured to have a number of portions, namely, a first portion (206) and a second portion (208) separated by an intermediate portion (210). See abstract lines 2-4, 6-8. Also, see col. 37, lines 28-30. Further, see Figure 27, etc.

However, the Examiner concedes that Satya et al. does not specifically mention or describe the second set of features spread across a smaller space than the first set. See lines 13-14 on page 3 of the Office Action mailed on March 7, 2006.

The Examiner is clearly mistaken in stating that Browning et al. teaches a second set (404) of features that is spread across a smaller space than a first set (403) of features. See Figure 4 and col. 4, lines 40-52. On the contrary, Browning et al. merely teaches that the first set has larger features (10% oversized), but does not teach that the features are spread across a smaller space.

In the opinion of the Examiner, Stearns et al. teaches performing the operations of scaling, translation, or rotation on an entire image or on any part thereof. However, Stearns et al. only teaches an affine transformation which means that the transformation always preserves the parallelism of lines in the input and output images. See col. 1, lines 30-37.

Thus, a combination of the structures of Satya et al., Browning et al., and Stearns et al. would still not produce the structure claimed by Applicants in claim 1, as amended, of Applicants' claimed invention.

Consequently, the three references cited by the Examiner do not, individually or collectively, teach, suggest, or render obvious the structure of Applicants' claimed invention, as claimed in claim 1, as amended, to one of ordinary skill in the art of fabricating semiconductors at the time that the invention was made.

Claims 2-5 are dependent on claim 1, as amended. As discussed previously, Applicants' claimed invention, as claimed in claim 1, as amended, would not have been obvious to one of ordinary skill in the art of fabricating semiconductors at the time that the invention was made. Thus, Applicants' claimed invention, as claimed

in claims 2-5, would also not have been obvious to one of ordinary skill in the art of semiconductors at the time that the invention was made.

In view of the foregoing, Applicants respectfully request the Examiner to withdraw the rejections to claims 1-5 under 35 U.S.C. §103 (a).

Claims 6-11

The Examiner has rejected claims 6-11 under 35 U.S.C. §103 (a) as being unpatentable over Satya et al. (US 6,528,818), Browning et al. (US 5,580,829) and in view of Stearns et al. (US 5,715,385) as applied to claims 1-5 above and further in view of Gallarda et al. (US 6,539,106).

Applicants respectfully disagree with the Examiner. Claims 6011 are dependent on claim 1. Applicants have amended claim 1. Support is provided in the specification at lines 10-13, 19-22 on page 8; lines 1-2, 9-12, 28-30 on page 9; and lines 3-15 on page 10..

Claim 1, as amended, of Applicants' claimed invention, claims a structure (250) that includes: a first set (245) of features located in a scribeline, the first set of features being a subset of product features; and a second set (255) of features located in the scribeline and adjacent to the first set of features, the second set of features differing from the first set of features in pattern factor, the second set of features spread across a smaller space than the first set of features, the second set of features created by geometric transformation of the product features, including rotating (33), space scaling (36), and linewidth scaling (39). See Figure 3 and Figure 5.

In contrast, the Satya et al. reference cited by the Examiner teaches a die array (202), as shown in figure 4A, that includes test dies (204) and product dies (206) separated by scribelines, as shown in Figure 4B, where test structures are located within the test die (204). See Figure 4B. Also, see Col. 11, lines 38-44.

The Examiner states that Satya et al. further teaches that each test die (204) is configured to have a number of portions, namely, a first portion (206) and a second portion (208) separated by an intermediate portion (210). See abstract lines 2-4, 6-8. Also, see col. 37, lines 28-30. Further, see Figure 27, etc.

However, the Examiner concedes that Satya et al. does not specifically mention or describe the second set of features spread across a smaller space than the first set. See lines 13-14 on page 3 of the Office Action mailed on March 7, 2006.

The Examiner is clearly mistaken in stating that Browning et al. teaches a second set (404) of features that is spread across a smaller space than a first set (403) of features. See Figure 4 and col. 4, lines 40-52. On the contrary, Browning et al. merely teaches that the first set has larger features (10% oversized), but does not teach that the features are spread across a smaller space.

In the opinion of the Examiner, Stearns et al. teaches performing the operations of scaling, translation, or rotation on an entire image or on any part thereof. However, Stearns et al. only teaches an affine transformation which means that the transformation always preserves the parallelism of lines in the input and output images. See col. 1, lines 30-37.

Thus, a combination of the structures of Satya et al., Browning et al., and Stearns et al. would still not produce the structure claimed by Applicants in claim 1, as amended, of Applicants' claimed invention.

Consequently, the four references cited by the Examiner do not, individually or collectively, teach, suggest, or render obvious the structure of Applicants' claimed invention, as claimed in claim 1, as amended, to one of ordinary skill in the art of fabricating semiconductors at the time that the invention was made.

Claims 6-11 are dependent on claim 1, as amended. As discussed previously, Applicants' claimed invention, as claimed in claim 1, as amended, would not have been obvious to one of ordinary skill in the art of fabricating semiconductors at the time that the invention was made. Thus, Applicants' claimed invention, as claimed

in claims 6-11, would also not have been obvious to one of ordinary skill in the art of semiconductor at the time that the invention was made.

In view of the foregoing, Applicants respectfully request the Examiner to withdraw the rejections to claims 6-11 under 35 U.S.C. §103 (a).

Conclusion

Applicants believe that all claims pending, including claims 1-11, of Applicants' claimed invention are now in condition for allowance so such action is earnestly solicited at the earliest possible date.

Pursuant to 37 C.F.R. 1.136 (a) (3), Applicants hereby request and authorize the U.S. Patent and Trademark Office to treat any concurrent or future reply that requires a petition for extension of time as incorporating a petition for extension of time for the appropriate length of time.

Should there be any additional charge or fee, including a Request for Continued Examination, an extension of time fee, or other fees under 37 C.F.R. 1.16 and 1.17, please charge Deposit Account No. 50-0221.

If a telephone interview would in any way expedite the prosecution of this application, the Examiner is invited to contact the undersigned at (408) 720-8300.

Respectfully submitted,
BLAKELY, SOKOLOFF, TAYLOR & ZAFMAN

Dated: November 27, 2006 /George Chen/
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